### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## General Description

The MAX5073 is a dual-output DC-DC converter with integrated high-side n-channel power MOSFETs. Each output can be configured either as a buck converter or a boost converter. The device is capable of operating from a wide 5.5 V to 23 V input voltage range. Each output is programmable down to 0.8 V in the buck mode and up to 28 V in the boost mode with an output voltage accuracy of $\pm 1 \%$. In the buck mode, converter 1 and converter 2 can deliver 2A and 1A, respectively. The output switching frequency of each converter can be programmed from 200 kHz to 2.2 MHz to avoid harmonics in a radio power supply or to reduce the size of the power supply. Each output operates $180^{\circ}$ out-of-phase thus reducing inputcapacitor ripple current, size, and cost. A SYNC input facilitates external frequency synchronization. Moreover, a CLKOUT output provides out-of-phase clock signal with respect to converter 2, allowing four-phase operation using two MAX5073 ICs in master-slave configuration.
The MAX5073 includes an internal digital soft-start that reduces inrush current, eliminates output-voltage overshoot, and ensures monotonic rise in output voltage during power-up. The device includes individual shutdown and a power-good output for each converter. Protection features include output short-circuit protection for buck mode and maximum dutycycle limit for boost operation, as well as thermal shutdown.
The MAX5073 is available in a thermally enhanced 28-pin thin QFN package that can dissipate 2.7 W at $+70^{\circ} \mathrm{C}$ ambient temperature. The device is rated for operation over the $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ extended, or $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ automotive temperature range.
Applications

- Point-of-Load DC-DC Converters
- Telecom Line Card
- Networking Line Card
- Power-Over-Ethernet Postregulation for PDs


## Ordering Information

| PART | TEMP RANGE | PIN- <br> PACKAGE | PACKAGE <br> CODE |
| :---: | :---: | :---: | :---: |
| MAX5073ETI | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 28 Thin QFN-EP* <br> $(5 \mathrm{~mm} \times 5 \mathrm{~mm})$ | T2855-6 |
| MAX5073ETI $+-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 28 Thin QFN-EP* <br> $(5 \mathrm{~mm} \times 5 \mathrm{~mm})$ | T2855-6 |  |

*EP = Exposed pad.
+Denotes lead-free package.
Ordering Information continued at end of data sheet.

## Features

- 4.5 V to 5.5 V or 5.5 V to 23 V Input Supply Voltage Range
- 0.8 V (Buck) to 28 V (Boost) Output Voltage
- Two Independent Output DC-DC Converters with Internal Power MOSFETs
- Each Output can be Configured in Buck or Boost Mode
- IOUT1 and IOUT2 of 2A and 1A (Respectively) in Buck Mode
- $180^{\circ}$ Out-of-Phase Operation
- Clock Output for Four Phase Operation
- Switching Frequency Programmable from 200kHz to 2.2MHz
- Digital Soft-Start and Sync Input
- Individual Converter Shutdown and Power-Good Output
- Short-Circuit Protection (Buck)/Maximum Duty-Cycle Limit (Boost)
- Thermal Shutdown
- Thermally Enhanced 28-Pin Thin QFN Package Dissipates up to 2.7 W at $+70^{\circ} \mathrm{C}$


## Pin Configuration



### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Absolute Maximum Ratings

```
V+ to PGND
```

$\qquad$

``` D.
``` \(\qquad\)
```-0.3 V to +25 VSGND to PGND.................................................... 0.3 V to +0.3 VVL to SGND................. -0.3 V to the lower of +6 V or ( \(\mathrm{V}++0.3 \mathrm{~V}\) )BST1/VDD1, BST2/VDD2, DRAIN_, PGOOD2, PGOOD1 toSGND
```

$\qquad$

```
BST1/VDD1 to SOURCE1,
    BST2/VDD2 to SOURCE2 .............................-0.3V to +6V
SOURCE_ to SGND........................................-0.6V to +25V
EN_ to SGND.....................................-0.3V to (VL to +0.3V)
CLKOUT, BYPASS, OSC, COMP1,
    COMP2, SYNC, FB_ to SGND..............-0.3V to (VL + 0.3V)
SOURCE1, DRAIN1 Peak Current
```

$\qquad$

``` .5 A for 1 ms
```

SOURCE2, DRAIN2 Peak Current $\qquad$ .3A for 1 ms VL, BYPASS to SGND Short Circuit .........................Continuous Continuous Power Dissipation ( $\mathrm{T}_{\mathrm{A}}=+70^{\circ} \mathrm{C}$ )

28-Pin Thin QFN (derate $21.3 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $+70^{\circ} \mathrm{C}$ ).. $2758 \mathrm{~mW}{ }^{*}$ Package Junction-to-Case Thermal Resistance ( $\theta_{\mathrm{JC}}$ )...... $2^{\circ} \mathrm{C} / \mathrm{W}$ Operating Temperature Ranges:

MAX5073ETI ( $\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$ )......................... $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
MAX5073ATI ( $\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$ )....................... $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$
Junction Temperature ...................................................... $+150^{\circ} \mathrm{C}$
Storage Temperature Range ............................ $65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$
Lead Temperature (soldering, 10s) ................................. $+300^{\circ} \mathrm{C}$
*As per JEDEC51 standard.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## Electrical Characteristics

$\left(\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}\right.$ or $\mathrm{V}+=5.5 \mathrm{~V}$ to $23 \mathrm{~V}, \mathrm{EN}_{-}=\mathrm{VL}, S Y N C=\mathrm{GND}, \mathrm{I}_{\mathrm{VL}}=0 \mathrm{~mA}, \mathrm{PGND}=\mathrm{SGND}, \mathrm{C}_{\mathrm{BYPASS}}=0.22 \mu \mathrm{~F}, \mathrm{C}_{\mathrm{VL}}=4.7 \mu \mathrm{~F}$ (ceramic), $R_{O S C}=10 \mathrm{k} \Omega$ (circuit of Figure 1), $\mathrm{T}_{A}=\mathrm{T}_{J}=\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$, unless otherwise noted.) (Note 1)

| PARAMETER | SYMBOL | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SYSTEM SPECIFICATIONS |  |  |  |  |  |  |  |
| Input Voltage Range | V+ | (Note 2) |  | 5.5 |  | 23.0 | V |
|  |  | VL = V+ |  | 4.5 |  | 5.5 |  |
| Operating Supply Current | $\mathrm{I}_{\mathrm{Q}}$ | VL unloaded, no switching, $\mathrm{V}_{\mathrm{FB}}=1 \mathrm{~V}$, $\mathrm{V}+=12 \mathrm{~V}, \mathrm{R}_{\mathrm{OSC}}=60 \mathrm{k} \Omega$ |  |  | 2.2 | 4 | mA |
| V+ Standby Supply Current | Istby | $\begin{aligned} & \mathrm{EN}==0, \mathrm{PGOOD} \text { floating, } \mathrm{V}+=12 \mathrm{~V}, \\ & \mathrm{R}_{\mathrm{OSC}}=60 \mathrm{k} \Omega \text { (MAXX5073ETI) } \end{aligned}$ |  |  | 0.6 | 1.2 | mA |
|  |  | $\begin{aligned} & \text { EN_= 0, PGOOD floating, V+ = 12V, } \\ & R_{O S C}=60 \mathrm{k} \Omega \text { (MAXX5073ATI) } \end{aligned}$ |  |  | 0.6 | 1.4 |  |
| Efficiency | $\eta$ | $\begin{aligned} & \mathrm{V}_{\text {OUT1 }}=3.3 \mathrm{~V} \text { at } 1.5 \mathrm{~A}, \\ & \mathrm{~V}_{\text {OUT2 }}=2.5 \mathrm{~V} \text { at } 0.75 \mathrm{~A} \\ & (\mathrm{fSW}=1.25 \mathrm{MHz}) \end{aligned}$ | $\mathrm{V}+=\mathrm{VL}=5 \mathrm{~V}$ |  | 82 |  | \% |
|  |  |  | $\mathrm{V}+=12 \mathrm{~V}$ |  | 80 |  |  |
|  |  |  | $\mathrm{V}+=16 \mathrm{~V}$ |  | 78 |  |  |
| STARTUP/VL REGULATOR |  |  |  |  |  |  |  |
| VL Undervoltage Lockout Trip Level | UVLO | VL falling |  | 3.95 | 4.1 | 4.25 | V |
| VL Undervoltage Lockout Hysteresis |  |  |  |  | 175 |  | mV |
| VL Output Voltage | VL | $\mathrm{V}+=5.5 \mathrm{~V}$ to 23 V , $\mathrm{I}_{\text {SOURCE }}=0$ to 40 mA |  | 4.9 | 5.2 | 5.5 | V |
| BYPASS OUTPUT |  |  |  |  |  |  |  |
| BYPASS Voltage | $V_{\text {BYPASS }}$ | $\mathrm{I}_{\text {BYPASS }}=0, \mathrm{R}_{\text {OSC }}=60 \mathrm{k} \Omega(\mathrm{MAX5073ETI})$ |  | 1.98 | 2.00 | 2.02 | V |
|  |  | $\mathrm{I}_{\text {BYPASS }}=0, \mathrm{R}_{\text {OSC }}=60 \mathrm{k} \Omega(\mathrm{MAX5073ATI})$ |  | 1.975 | 2.00 | 2.025 |  |
| BYPASS Load Regulation | $\Delta \mathrm{V}_{\text {BYPASS }}$ | $0 \leq \mathrm{I}_{\text {BYPASS }} \leq 50 \mu \mathrm{~A}, \mathrm{R}_{\text {OSC }}=60 \mathrm{k} \Omega$ |  | 0 | 2 | 10 | mV |
| SOFT-START |  |  |  |  |  |  |  |
| Digital Ramp Period |  | Internal 6-bit DAC |  |  | 2048 |  | fosc clock cycles |
| Soft-Start Steps |  |  |  |  | 64 |  | Steps |

## Electrical Characteristics (continued)

$\left(\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}\right.$ or $\mathrm{V}+=5.5 \mathrm{~V}$ to $23 \mathrm{~V}, \mathrm{EN}_{-}=\mathrm{VL}, \mathrm{SYNC}=\mathrm{GND}, \mathrm{I}_{\mathrm{VL}}=0 \mathrm{~mA}, \mathrm{PGND}=\mathrm{SGND}, \mathrm{C}_{\mathrm{BYPASS}}=0.22 \mu \mathrm{~F}, \mathrm{C}_{\mathrm{VL}}=4.7 \mu \mathrm{~F}$ (ceramic), $R_{O S C}=10 \mathrm{k} \Omega$ (circuit of Figure 1), $\mathrm{T}_{\mathrm{A}}=\mathrm{T}_{J}=\mathrm{T}_{\text {MIN }}$ to $T_{\text {MAX }}$, unless otherwise noted.) (Note 1)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| VOLTAGE-ERROR AMPLIFIER |  |  |  |  |  |  |
| FB_Input Bias Current | $\mathrm{I}_{\mathrm{B}(\mathrm{EA})}$ |  |  |  | 250 | nA |
| FB_ Input Voltage Set Point |  | $0^{\circ} \mathrm{C} \leq \mathrm{T}_{\mathrm{A}} \leq+70^{\circ} \mathrm{C}$ | 0.792 | 0.8 | 0.808 | V |
|  |  | $-40^{\circ} \mathrm{C} \leq \mathrm{T}_{\mathrm{A}} \leq+85^{\circ} \mathrm{C}$ | 0.788 | 0.8 | 0.812 |  |
|  |  | $-40^{\circ} \mathrm{C} \leq \mathrm{T}_{J} \leq+125^{\circ} \mathrm{C}$ (MAX5073ATI only) | 0.788 | 0.8 | 0.812 |  |
| FB_to COMP Transconductance | gM | $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 1.25 | 2 | 2.70 | mS |
|  |  | $40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 1.2 | 2 | 2.9 |  |
|  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ (MAX5073ATI only) | 1.2 | 2 | 2.9 |  |
| INTERNAL PMOSFETS |  |  |  |  |  |  |
| On-Resistance Converter 1 | RoN1 | $I_{\text {SWITCH }}=100 \mathrm{~mA}$, $\mathrm{V}_{\mathrm{BST} 1} / \mathrm{V}_{\mathrm{DD} 1}$ to $\mathrm{V}_{\text {SOURCE1 }}=5.2 \mathrm{~V}$ (MAX5073ETI) |  | 195 | 290 | $\mathrm{m} \Omega$ |
|  |  | ISWITCH $=100 \mathrm{~mA}$, $\mathrm{V}_{\mathrm{BST}} 1 / \mathrm{V}_{\mathrm{DD} 1}$ to $\mathrm{V}_{\text {SOURCE1 }}=5.2 \mathrm{~V}$ (MAX5073ATI) |  | 195 | 330 |  |
|  |  | $I_{\text {SWITCH }}=100 \mathrm{~mA}$, $\mathrm{V}_{\mathrm{BST} 1} / \mathrm{V}_{\mathrm{DD} 1}$ to $\mathrm{V}_{\text {SOURCE1 }}=4.5 \mathrm{~V}$ (MAX5073ETI) |  |  |  |  |
|  |  | $\begin{aligned} & \text { ISWITCH }=100 \mathrm{~mA} \text {, } \\ & \mathrm{V}_{\text {BST } 1} / \mathrm{V}_{\text {DD } 1 \text { to }} \mathrm{V}_{\text {SOURCE1 }}=4.5 \mathrm{~V} \\ & \text { (MAX5073ATI) } \end{aligned}$ |  |  |  |  |
| On-Resistance Converter 2 | Ron2 | $\begin{aligned} & \text { ISWITCH }=100 \mathrm{~mA}, \\ & \text { V }_{\text {BST2 } 2} N_{\text {DD2 }} \text { to } \mathrm{V}_{\text {SOURCE2 }}=5.2 \mathrm{~V} \end{aligned}$ |  | 330 | 630 | $\mathrm{m} \Omega$ |
|  |  | $\begin{aligned} & \text { ISWITCH }=100 \mathrm{~mA}, \\ & \text { V }_{\text {BST2 } 2} N_{\text {DD2 }} \text { to } \mathrm{V}_{\text {SOURCE2 }}=4.5 \mathrm{~V} \end{aligned}$ |  | 350 | 690 |  |
| Minimum Converter 1 Output Current | lout1 | $\mathrm{V}_{\text {OUT1 }}=3.3 \mathrm{~V}, \mathrm{~V}+=12 \mathrm{~V}($ Note 3$)$ |  | 2 |  | A |
| Minimum Converter 2 Output Current | Iout2 | $\mathrm{V}_{\text {OUT2 }}=2.5 \mathrm{~V}, \mathrm{~V}+=12 \mathrm{~V}($ Note 3) |  | 1 |  | A |
| Converter 1 MOSFET Leakage Current | ILK1 | $\mathrm{EN} 1=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=23 \mathrm{~V}$ |  |  | 10 | $\mu \mathrm{A}$ |
| Converter 2 MOSFET Leakage Current | ILK2 | $\mathrm{EN} 2=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=23 \mathrm{~V}$ |  |  | 10 | $\mu \mathrm{A}$ |
| INTERNAL SWITCH CURRENT LIMIT |  |  |  |  |  |  |
| Current-Limit Converter 1 | ${ }^{\text {CL1 }}$ | V+ = 12V (MAX5073ETI) | 2.3 | 3 | 4.3 | A |
|  |  | V+ = 12V (MAX5073ATI) | 2.3 | 3 | 4.6 |  |
| Current-Limit Converter 2 | $\mathrm{I}_{\text {CL2 }}$ | MAX5073ETI | 1.38 | 1.8 | 2.10 | A |
|  |  | MAX5073ATI | 1.38 | 1.8 | 2.20 |  |

## Electrical Characteristics (continued)

$\left(\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}\right.$ or $\mathrm{V}+=5.5 \mathrm{~V}$ to $23 \mathrm{~V}, \mathrm{EN}_{-}=\mathrm{VL}, \mathrm{SYNC}=\mathrm{GND}, \mathrm{I}_{\mathrm{VL}}=0 \mathrm{~mA}, \mathrm{PGND}=\mathrm{SGND}, \mathrm{C}_{\mathrm{BYPASS}}=0.22 \mu \mathrm{~F}, \mathrm{C}_{\mathrm{VL}}=4.7 \mu \mathrm{~F}$ (ceramic), $R_{O S C}=10 \mathrm{k} \Omega$ (circuit of Figure 1), $\mathrm{T}_{\mathrm{A}}=\mathrm{T}_{J}=\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$, unless otherwise noted.) (Note 1)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| INTERNAL OSCILLATOR/SYNC |  |  |  |  |  |  |
| Maximum Duty Cycle | $\mathrm{D}_{\text {MAX }}$ | SYNC = SGND, fSW $=1.25 \mathrm{MHz}$ | 84 | 86 | 95 | \% |
|  |  | SYNC = SGND, $\mathrm{f}_{\text {SW }}=2.2 \mathrm{MHz}$ | 84 | 86 | 95 |  |
| Switching Frequency Range | fsw | Each converter | 200 |  | 2200 | kHz |
| Switching Frequency | $\mathrm{f}_{\text {SET }}$ | $\mathrm{R}_{\text {OSC }}=10 \mathrm{k} \Omega$, each converter | 1125 | 1250 | 1375 | kHz |
| Switching Frequency Accuracy |  | $5.6 \mathrm{k} \Omega \leq \mathrm{R}_{\mathrm{OSC}} \leq 56 \mathrm{k} \Omega$, $1 \%$ each converter | -15 |  | +15 | \% |
| SYNC Frequency Range | $\mathrm{f}_{\text {SYNC }}$ | SYNC input frequency is twice the individual converter frequency | 400 |  | 4400 | kHZ |
| SYNC High Threshold | $\mathrm{V}_{\text {SYNCH }}$ |  | 2.4 |  |  | V |
| SYNC Low Threshold | $\mathrm{V}_{\text {SYNCL }}$ |  |  |  | 0.8 | V |
| SYNC Input Min Pulse Width | $\mathrm{t}_{\text {SYNCIN }}$ |  |  | 100 |  | ns |
| Clock Output Phase Delay | $\begin{aligned} & \text { CLKOUT } \\ & \text { PHASE } \end{aligned}$ | $\mathrm{R}_{\mathrm{OSC}}=60 \mathrm{k} \Omega, 1 \%$, with respect to converter 2 / SOURCE2 waveform |  | 45 |  | degrees |
| SYNC to SOURCE1 Phase Delay | SYNC ${ }_{\text {PHASE }}$ | $\mathrm{R}_{\text {OSC }}=60 \mathrm{k} \Omega, 1 \%$ |  | 45 |  | degrees |
| Clock Output High Level | $\mathrm{V}_{\text {CLKOUTH }}$ | $\mathrm{VL}=5.2 \mathrm{~V}$, sourcing 5 mA | 4 |  |  | V |
| Clock Output Low Level | $\mathrm{V}_{\text {CLKOUTL }}$ | $\mathrm{VL}=5.2 \mathrm{~V}$, sinking 5mA |  |  | 0.4 | V |
| EN_ INPUTS |  |  |  |  |  |  |
| EN_Input High Threshold | $\mathrm{V}_{\text {IH }}$ | $\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}$ | 2.4 | 1.8 |  | V |
| EN_Input Low Threshold | $\mathrm{V}_{\text {IL }}$ | $\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}$ |  | 1.2 | 0.8 | V |
| EN_Bias Current | $\mathrm{I}_{\mathrm{B} \text { (EN) }}$ |  |  |  | 250 | nA |
| POWER-GOOD OUTPUT (PGOOD_) |  |  |  |  |  |  |
| PGOOD_ Threshold | PGOODVTH_ | PGOOD goes high after $V_{\text {OUT }}$ crosses PGOOD_threshold | 90 | 92.5 | 95 | \%Vout |
| PGOOD_ Output Voltage | $\mathrm{V}_{\text {PGOOD_ }}$ | $\mathrm{I}_{\text {SINK }}=3 \mathrm{~mA}$ (MAX5073ETI) |  |  | 0.4 | V |
|  |  | ISINK $=3 \mathrm{~mA}$ (MAX5073ATI) |  |  | 0.52 |  |
| PGOOD_Output Leakage Current | ILKPGOOD_ | $\begin{aligned} & \mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{PGOOD}_{-}}=23 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{FB}_{-}}=1 \mathrm{~V} \end{aligned}$ |  |  | 1 | $\mu \mathrm{A}$ |
| THERMAL MANAGEMENT |  |  |  |  |  |  |
| Thermal Shutdown | $\mathrm{T}_{\text {SHDN }}$ | Junction temperature |  | +150 |  | ${ }^{\circ} \mathrm{C}$ |
| Thermal Hysteresis | $\mathrm{T}_{\text {HYST }}$ | Junction temperature |  | 30 |  | ${ }^{\circ} \mathrm{C}$ |

Note 1: Specifications at $-40^{\circ} \mathrm{C}$ are guaranteed by design and not production tested.
Note 2: Operating supply range $(\mathrm{V}+$ ) is guaranteed by VL line regulation test. Connect $\mathrm{V}+$ to VL for 5 V operation.
Note 3: Output current may be limited by the power dissipation of the package, refer to the Power Dissipation section in the Applications Information.

## Typical Operating Characteristics

$\left(\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}\right.$, unless otherwise noted.)


## Typical Operating Characteristics (continued)

$\left(\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}\right.$, unless otherwise noted.)

LINE-TRANSIENT RESPONSE
(BUCK CONVERTER)

$100 \mu \mathrm{~s} / \mathrm{div}$


CONVERTER 1 LOAD-TRANSIENT RESPONSE (BUCK CONVERTER)


OUT-OF-PHASE OPERATION


Typical Operating Characteristics (continued)
( $\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise noted.)


### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Typical Operating Characteristics (continued)

$\left(\mathrm{V}+=\mathrm{VL}=5.2 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}\right.$, unless otherwise noted.)


## Pin Description

| PIN | NAME | FUNCTION |
| :---: | :---: | :---: |
| 1 | CLKOUT | Clock Output. CLKOUT is $45^{\circ}$ phase-shifted with respect to converter 2 (SOURCE2, Figure 3). Connect CLKOUT (master) to the SYNC of a second MAX5073 (slave) for a four-phase converter. |
| 2 | BST2/VDD2 | Buck Converter Operation-Bootstrap Flying-Capacitor Connection for Converter 2. Connect BST2/ VDD2 to an external ceramic capacitor and diode according to the standard application circuit (Figure 1). Boost Converter Operation-Driver Bypass Capacitor Connection. Connect a low-ESR $0.1 \mu \mathrm{~F}$ ceramic capacitor from BST2/VDD2 to PGND (Figure 8). |
| 3, 4 | DRAIN2 | Connection to Converter 2 Internal MOSFET Drain. Buck converter operation-use the MOSFET as a high-side switch and connect DRAIN2 to the input supply. Boost converter operation-use the MOSFET as a low-side switch and connect DRAIN2 to the inductor and diode junction (Figure 8). |
| 5 | EN2 | Active-High Enable Input for Converter 2. Drive EN2 low to shut down converter 2, drive EN2 high for normal operation. Use EN2 in conjunction with EN1 for supply sequencing. Connect to VL for always-on operation. |
| 6 | FB2 | Feedback Input for Converter 2. Connect FB2 to a resistive divider between converter 2's output and SGND to adjust the output voltage. To set the output voltage below 0.8 V , connect FB2 to a resistive voltage-divider from BYPASS to regulator 2's output (Figure 5). See the Setting the Output Voltage section. |
| 7 | COMP2 | Compensation Connection for Converter 2. See the Compensation section to compensate converter 2's control loop. |
| 8 | SYNC | External Clock Synchronization Input. Connect SYNC to a 400 kHz to 4400 kHz clock to synchronize the switching frequency with the system clock. Each converter frequency is one half the frequency applied to SYNC. Connect SYNC to SGND when not used. |
| 9 | N.C. | No Connection. Not internally connected. |

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Pin Description (continued)

| PIN | NAME | FUNCTION |
| :---: | :---: | :---: |
| 10 | OSC | Oscillator Frequency Set Input. Connect a resistor from OSC to SGND (ROSC) to set the switching frequency (see the Oscillator section). Set ROSC for equal to or lower oscillator frequency than the SYNC input frequency when using external synchronization ( $0.2 \mathrm{f}_{\text {SYNC }}<\mathrm{f}_{\mathrm{OSC}}<1.2 \mathrm{f}_{\text {SYNC }}$ ). $R_{\text {OSC }}$ is still required when an external clock is connected to the SYNC input. |
| 11 | V+ | Input Supply Voltage. V+ voltage range from 5.5 V to 23 V . Connect the $\mathrm{V}+$ and VL together for 4.5 V to 5.5 V input operation. Bypass with a minimum $0.1 \mu \mathrm{~F}$ ceramic capacitor to SGND. |
| 12, 13 | VL | Internal 5.2V Linear Regulator Output. Use VL to drive the high-side switch at BST1/VDD1 and BST2/VDD2. Bypass VL with a $0.1 \mu \mathrm{~F}$ capacitor to PGND and a $4.7 \mu \mathrm{~F}$ ceramic capacitor to SGND. |
| 14 | BYPASS | 2.0V Output. Bypass to SGND with a $0.22 \mu \mathrm{~F}$ or greater ceramic capacitor. |
| 15 | COMP1 | Compensation Connection for Converter 1 (See the Compensation Section) |
| 16 | FB1 | Feedback Input for Converter 1. Connect FB1 to a resistive divider between converter 1's output and SGND to program the output voltage. To set the output voltage below 0.8 V , connect FB1 to a resistive voltage- divider from BYPASS to regulator 1's output (Figure 5). See the Setting the Output Voltage section. |
| 17 | EN1 | Active-High Enable Input for Converter 1. Drive EN1 low to shut down converter 1, drive EN1 high for normal operation. Use EN1 in conjunction with EN2 for supply sequencing. Connect to VL for always-on operation. |
| 18, 19 | DRAIN1 | Connection to the Converter 1 Internal MOSFET Drain. <br> Buck converter operation-use the MOSFET as a high-side switch and connect DRAIN1 to the input supply. Boost converter operation-use the MOSFET as a low-side switch and connect DRAIN1 to the inductor and diode junction. |
| 20 | BST1/VDD1 | Buck Converter Operation-Bootstrap Flying-Capacitor Connection for Converter 1. Connect BST1/VDD1 to an external ceramic capacitor and diode according to the Standard Application Circuit (Figure 1). Boost Converter Operation-Driver Bypass Capacitor Connection. Connect a low-ESR $0.1 \mu \mathrm{~F}$ ceramic capacitor from BST1/VDD1 to PGND. |
| 21 | PGOOD1 | Converter 1 Power-Good Output. Open-drain output goes low when converter 1's output falls below $92.5 \%$ of its set regulation voltage. Use PGOOD1, PGOOD2, EN1, and EN2 to sequence the converters. |
| 22 | PGOOD2 | Converter 2 Power-Good Output. Open-drain output goes low when converter 2's output falls below $92.5 \%$ of its set regulation voltage. |
| 23, 24 | SOURCE1 | Connection to the Converter 1 Internal MOSFET Source. <br> Buck converter operation-connect SOURCE1 to the switched side of the inductor as shown in Figure 1. <br> Boost converter operation-connect SOURCE1 to PGND. |
| 25 | SGND | Signal Ground. Connect SGND to the exposed pad. Connect SGND and PGND together at a single point. |
| 26 | PGND | Power Ground. Connect rectifier diode anode, input capacitor negative, output capacitor negative, and VL bypass capacitor returns to PGND. |
| 27, 28 | SOURCE2 | Connection to the Converter 2 Internal MOSFET Source. <br> Buck converter operation-connect SOURCE2 to the switched side of the inductor as shown in Figure 1. Boost converter operation-connect SOURCE2 to PGND (Figure 8). |
| EP | SGND | Exposed Paddle. Connect to SGND. Solder EP to the SGND plane for better thermal performance. |



Figure 1. MAX5073 Dual Buck Regulator Application Circuit

## Detailed Description

## PWM Controller

The MAX5073 converter uses a pulse-width modulation (PWM) voltage-mode control scheme for each out-ofphase controller. It is nonsynchronous rectification and uses an external low-forward-drop Schottky diode for rectification. The controller generates the clock signal by dividing down the internal oscillator or the SYNC input when driven by an external clock, so each controller's switching frequency equals half the oscillator frequency ( $\mathrm{fsw}^{2}=\mathrm{fosc}^{\prime} / 2$ ). An internal transconductance error amplifier produces an integrated error voltage at the COMP pin, providing high DC accuracy. The voltage at COMP sets the duty cycle using a PWM comparator and a ramp generator. At each rising edge of the clock, converter 1's highside n -channel MOSFET turns on and remains on until either the appropriate or maximum duty cycle is reached, or the maximum current limit for the switch is detected. Converter 2 operates out-of-phase, so the second highside MOSFET turns on at each falling edge of the clock.
In the case of buck operation (Figure 1), during each highside MOSFET?s on-time, the associated inductor current
ramps up. During the second half of the switching cycle, the high-side MOSFET turns off and forward biases the Schottky rectifier. During this time, the SOURCE voltage is clamped to $0.4 \mathrm{~V}\left(\mathrm{~V}_{\mathrm{D}}\right)$ below ground. The inductor releases the stored energy as its current ramps down, and provides current to the output. The bootstrap capacitor is also recharged from the inductance energy when the MOSFET turns off. The circuit goes in discontinuous conduction mode operation at light load, when the inductor current completely discharges before the next cycle commences. Under overload conditions, when the inductor current exceeds the peak current limit of the respective switch, the high-side MOSFET turns off quickly and waits until the next clock cycle.
In the case of boost operation, the MOSFET is a low-side switch (Figure 8). During each on-time, the inductor current ramps up. During the second half of the switching cycle, the low-side switch turns off and forward biases the Schottky diode. During this time, the DRAIN voltage is clamped to $0.4 \mathrm{~V}\left(\mathrm{~V}_{\mathrm{D}}\right)$ above $\mathrm{V}_{\text {OUT }}$ and the inductor provides energy to the output as well às replenishes the output capacitor charge.

## Internal Oscillator/Out-of-Phase Operation

The internal oscillator generates the $180^{\circ}$ out-of-phase clock signal required by each regulator. The internal oscillator frequency is programmable from 400 kHz to 4.4 MHz using a single $1 \%$ resistor at ROSC. Use the following equation to calculate $\mathrm{R}_{\mathrm{OSC}}$ :

$$
\mathrm{R}_{\mathrm{OSC}}=\frac{25 \times 10^{9}}{\mathrm{f}_{\mathrm{OSC}}}
$$

where foSC is the internal oscillator frequency in hertz and ROSC in ohms.
The two independent regulators in the MAX5073 switch $180^{\circ}$ out-of-phase to reduce input filtering requirements, to reduce electromagnetic interference (EMI), and to improve efficiency. This effectively lowers component cost and saves board space, making the MAX5073 ideal for cost-sensitive applications.
With dual synchronized out-of-phase operation, the MAX5073's high-side MOSFETs turn on $180^{\circ}$ out-ofphase. The instantaneous input current peaks of both regulators do not overlap, resulting in reduced RMS ripple current and input voltage ripple. This reduces the required input capacitor ripple current rating, allows for fewer or less expensive capacitors, and reduces shielding requirements for EMI. The out-of-phase waveforms in the Typical Operating Characteristics demonstrate synchronized $180^{\circ}$ out-of-phase operation.

## Synchronization (SYNC)/ Clock Output (CLKOUT)

The main oscillator can be synchronized to the system clock by applying an external clock (fSYNC) at SYNC. The fSYNC frequency must be twice the required operating frequency of an individual converter. Use a TTL logic signal for the external clock with at least a 100ns pulse width. ROSC is still required when using external synchronization. Program the internal oscillator frequency so $0.2 f_{S Y N C}<\mathrm{f}_{\mathrm{SSC}}<1.2 \mathrm{f}_{\text {SYNC }}$. The rising edge of $\mathrm{f}_{\text {SYNC }}$ synchronizes the turn-on edge of the internal MOSFET (see Figure 3).

$$
\mathrm{R}_{\mathrm{OSC}}=\frac{25 \times 10^{9}}{\mathrm{f}_{\mathrm{OSC}}}
$$

where fosc is the internal oscillator frequency in hertz and ROSC in ohms, fOSC $=2 \times f$ SW.
Two MAX5073s can be connected in the master-slave configuration for four ripple-phase operation. The MAX5073 provides a clock output (CLKOUT) that is $45^{\circ}$
phase-shifted with respect to the internal switch turn-on edge. Feed the CLKOUT of the master to the SYNC input of the slave. The effective input ripple switching frequency shall be four times the individual converter's switching frequency. When driving the master converter using external clock at SYNC, set the clock duty cycle to $50 \%$ for a $90^{\circ}$ phase-shifted operation.

## Input Voltage (V+)/Internal Linear Regulator (VL)

All internal control circuitry operates from an internally regulated nominal voltage of 5.2 V (VL). At higher input voltages $(\mathrm{V}+)$ of 5.5 V to $23 \mathrm{~V}, \mathrm{VL}$ is regulated to 5.2 V . At 5.5 V or below, the internal linear regulator operates in dropout mode, where VL follows $\mathrm{V}+$. Depending on the load on VL, the dropout voltage can be high enough to reduce VL below the undervoltage lockout (UVLO) threshold.
For input voltages of less than 5.5 V , connect $\mathrm{V}+$ and VL together. The load on VL is proportional to the switching frequency of converter 1 and converter 2 . See the Dropout Voltage vs. Switching Frequency graph in the Typical Operating Characteristics. For input voltage ranges higher than 5.5 V , use the internal regulator.
Bypass V+ to SGND with a low-ESR, $0.1 \mu \mathrm{~F}$ or greater ceramic capacitor placed close to the MAX5073. Current spikes from VL may disturb internal circuitry powered by VL. Bypass VL with a low-ESR, ceramic $0.1 \mu \mathrm{~F}$ capacitor to PGND and $4.7 \mu \mathrm{~F}$ capacitor to SGND.

## Undervoltage Lockout/Soft-Start

The MAX5073 includes an undervoltage lockout with hysteresis and a power-on-reset circuit for converter turnon and monotonic rise of the output voltage. The rising UVLO threshold is internally set to 4.3 V with a 175 mV hysteresis. Hysteresis at UVLO eliminates "chattering" during startup. When VL drops below UVLO, the internal switches are turned off.
Digital soft-start is provided internally to reduce input surge currents and glitches at the input during turn-on. When UVLO is cleared and EN_ is high, digital soft-start slowly ramps up the internal reference voltage in 64 steps. The total soft-start period is 2048 switching cycles of the internal oscillator.
To calculate the soft-start period, use the following equation:

$$
\mathrm{t}_{\mathrm{SS}}=\frac{2048}{\mathrm{f}_{\mathrm{OSC}}}
$$

where fOSC is the internal oscillator frequency in hertz, which is twice the switching frequency of each converter.


Figure 2. Functional Diagram

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs



Figure 3. Synchronized Controllers

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Enable

The MAX5073 dual converter provides separate enable inputs EN1 and EN2 to individually control or sequence the output voltages. These active-high enable inputs are TTL compatible. Pulling EN_ high ramps up the reference slowly, which provides soft-start at the outputs. Forcing the EN_ low externally disables the individual output and generates a PGOOD_signal. Use EN1, EN2, and PGOOD1 for sequencing (see Figure 4). Connect PGOOD1 to EN2 to make sure converter 1's output is within regulation before converter 2 starts. Add an RC network from VL to EN1 and EN2 to delay the individual converter. A larger RC time constant means a more delayed output. Sequencing reduces input inrush current and possible chattering. Connect the EN_ to VL for always-on operation.

## PGOOD_

Converter 1 and converter 2 includes a power-good flag, PGOOD1 and PGOOD2, respectively. Since PGOOD is an open-drain output and can sink 3 mA while providing the TTL logic-low signal, pull PGOOD to a logic voltage to provide a logic-level output. PGOOD goes low when converter 1's output drops to $92.5 \%$ of its nominal regulated voltage. Connect PGOOD to SGND or leave unconnected if not used.

## Current Limit

The internal switch current of each converter is sensed using an internal current mirror. Converter 1 and converter 2 have 2 A and 1A internal switches. When the peak switch current crosses the current-limit threshold of 3 A (typ) and 1.8 A (typ) for converter 1 and converter 2 , respectively, the on cycle is terminated immediately and the inductor is allowed to discharge. The next cycle resumes at the next clock pulse.
In deep overload or short-circuit conditions when the FB voltage drops below 0.4 V , the switching frequency is reduced to $1 / 4 \times$ fSW to provide sufficient time for the inductor to discharge. During overload conditions, if the voltage across the inductor is not high enough to allow for the inductor current to properly discharge, current runaway may occur. Current runaway can destroy the device in spite of internal thermal-overload protection. Reducing the switching frequency during overload conditions prevents current runaway.

## Thermal-Overload Protection

During continuous short circuit or overload at the output, the power dissipation in the IC can exceed its limit. Internal thermal shutdown is provided to avoid irreversible damage to the device. When the die temperature or junction temperature exceeds $+150^{\circ} \mathrm{C}$, an on-chip thermal sensor shuts down the device, forcing the internal switches to turn off, allowing the IC to cool. The thermal sensor turns the part on again after the junction temperature cools by $+30^{\circ} \mathrm{C}$. During thermal shutdown, both regulators shut down, PGOOD_go low, and soft-start resets.


Figure 4. Power-Supply Sequencing Configurations

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Applications Information

## Setting the Switching Frequency

The controller generates the clock signal by dividing down the internal oscillator or the SYNC input signal when driven by an external oscillator. The switching frequency equals half the oscillator frequency ( $f$ SW $=\mathrm{f}_{\mathrm{OSC}} / 2$ ). The internal oscillator frequency is set by a resistor (ROSC) connected from OSC to SGND. The relationship between fsW and ROSC is:

$$
\mathrm{R}_{\mathrm{OSC}}=\frac{12.5 \times 10^{9}}{\mathrm{f}_{\mathrm{SW}}}
$$

where fSW and fOSC are in hertz, and ROSC is in ohms. For example, a 1250 kHz switching frequency is set with ROSC $=10 \mathrm{k} \Omega$. Higher frequencies allow designs with lower inductor values and less output capacitance. Consequently, peak currents and 12 R losses are lower at higher switching frequencies, but core losses, gatecharge currents, and switching losses increase.
A rising clock edge on SYNC is interpreted as a synchronization input. If the SYNC signal is lost, the internal oscillator takes control of the switching rate, returning the switching frequency to that set by ROSC. This maintains output regulation even with intermittent SYNC signals. When an external synchronization signal is used, ROSC should be set for the oscillator frequency to be lower than or equal to the SYNC rate (fSYNC).

## Buck Converter

## Effective Input Voltage Range

Although the MAX5073 converters can operate from input supplies ranging from 5.5 V to 23 V , the input voltage range can be effectively limited by the MAX5073 duty-cycle limitations for a given output voltage. The maximum input voltage is limited by the minimum on-time (tON(MIN)):

$$
\mathrm{V}_{\mathrm{IN}(\mathrm{MAX})} \leq \frac{\mathrm{V}_{\mathrm{OUT}}}{\mathrm{t}_{\mathrm{ON}(\mathrm{MIN})} \times \mathrm{f}_{\mathrm{SW}}}
$$

where $\mathrm{t}_{\mathrm{ON}(\mathrm{MIN})}$ is 100 ns . The minimum input voltage is limited by the maximum duty cycle ( $D M A X=88$ ):

$$
\mathrm{V}_{\mathrm{IN}(\mathrm{MIN})}=\left[\frac{\mathrm{V}_{\mathrm{OUT}}+\mathrm{V}_{\mathrm{DROP}}}{0.88}\right]+\mathrm{V}_{\mathrm{DROP} 2}-\mathrm{V}_{\mathrm{DROP} 1}
$$

where $\mathrm{V}_{\mathrm{DROP}}$ is the total parasitic voltage drops in the inductor discharge path, which includes the forward voltage drop $\left(\mathrm{V}_{\mathrm{D}}\right)$ of the rectifier, the series resistance of the inductor, and the PC board resistance. $V_{\text {DROP2 }}$ is the total resistance in the charging path, which includes the on-resistance of the high-side switch, the series resistance of the inductor, and the PC board resistance.

## Setting the Output Voltage

For 0.8 V or greater output voltages, connect a voltagedivider from OUT_ to FB_ to SGND (Figure 5). Select $R_{B}$ (FB_ to SGND resistor) to between $1 \mathrm{k} \Omega$ and $10 \mathrm{k} \Omega$. Calculate $\mathrm{R}_{\mathrm{A}}$ (OUT_ to $\mathrm{FB}_{\text {_ }}$ resistor) with the following equation:

$$
\mathrm{R}_{\mathrm{A}}=\mathrm{R}_{\mathrm{B}}\left[\left(\frac{\mathrm{~V}_{\mathrm{OUT}}}{\mathrm{~V}_{\mathrm{FB}}}\right)-1\right]
$$

where $\mathrm{V}_{\mathrm{FB}}=0.8 \mathrm{~V}$ (see the Electrical Characteristics table) and $\bar{V}_{\text {OUT_ }}$ can range from $\mathrm{V}_{\mathrm{FB}}$ to 28 V (boost operation).
For output voltages below 0.8 V , set the MAX5073 output voltage by connecting a voltage-divider from the output to FB_ to BYPASS (Figure 5). Select $R_{C}$ (FB to BYPASS resistor) higher than a $50 \mathrm{k} \Omega$ range. Calculate $\mathrm{R}_{\mathrm{A}}$ with the following equation:

$$
R_{A}=R_{C}\left[\frac{V_{F B}-V_{O U T}}{V_{B Y P A S S}-V_{F B}}\right]
$$

where $\mathrm{V}_{\mathrm{FB}}=0.8 \mathrm{~V}, \mathrm{~V}_{\mathrm{BYPASS}}=2 \mathrm{~V}$ (see the Electrical Characteristics table), and $\mathrm{V}_{\mathrm{OUT}}$ _ can range from OV to VFB_.


Figure 5. Adjustable Output Voltage

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Inductor Selection

Three key inductor parameters must be specified for operation with the MAX5073: inductance value (L), peak inductor current ( $\mathrm{l}_{\mathrm{L}}$ ), and inductor saturation current (ISAT). The minimum required inductance is a function of operating frequency, input-to-output voltage differential and the peak-to-peak inductor current ( $\Delta \mathrm{I}_{\mathrm{L}}$ ). Higher $\Delta \mathrm{I}_{\mathrm{L}}$ allows for a lower inductor value while a lower $\Delta \mathrm{I}_{\mathrm{L}}$ requires a higher inductor value. A lower inductor value minimizes size and cost, improves large-signal transient response, but reduces efficiency due to higher peak currents and higher peak-to-peak output ripple voltage for the same output capacitor. On the other hand, higher inductance increases efficiency by reducing the ripple current. However, resistive losses due to extra wire turns can exceed the benefit gained from lower ripple current levels, especially when the inductance is increased without also allowing for larger inductor dimensions. A good compromise is to choose $\Delta \mathrm{I}_{\mathrm{L}}$ equal to $30 \%$ of the full load current. To calculate the inductance use the following equation:

$$
\mathrm{L}=\frac{\mathrm{V}_{\mathrm{OUT}}\left(\mathrm{~V}_{\mathrm{IN}}-\mathrm{V}_{\mathrm{OUT}}\right)}{\mathrm{V}_{\mathrm{IN}} \times \mathrm{f}_{\mathrm{SW}} \times \Delta \mathrm{I}_{\mathrm{L}}}
$$

where $\mathrm{V}_{\mathrm{IN}}$ and $\mathrm{V}_{\text {OUT }}$ are typical values (so that efficiency is optimum for typical conditions). The switching frequency is set by ROSC (see the Setting the Switching Frequency section). The peak-to-peak inductor current, which reflects the peak-to-peak output ripple, is worse at the maximum input voltage. See the Output Capacitor Selection section to verify that the worst-case output ripple is acceptable. The inductor saturating current is also important to avoid runaway current during output overload and continuous short circuit. Select the ISAT to be higher than the maximum peak current limits of 4.5A and 2.2A for converter 1 and converter 2.

## Input Capacitors

The discontinuous input current waveform of the buck converter causes large ripple currents at the input. The switching frequency, peak inductor current, and the allowable peak-to-peak voltage ripple dictate the input capacitance requirement. Increasing the switching frequency or the inductor value lowers the peak to average current ratio, yielding a lower input capacitance requirement. Note that two converters of MAX5073 run $180^{\circ}$ out-of-phase, thereby effectively doubling the switching frequency at the input.

The input ripple waveform would be unsymmetrical due to the difference in load current and duty cycle between converter 1 and converter 2 . The input ripple is comprised of $\Delta \mathrm{V}_{\mathrm{Q}}$ (caused by the capacitor discharge) and $\Delta \mathrm{V}_{\mathrm{ESR}}$ (caused by the ESR of the capacitor). A higher load converter dictates the ESR requirement, while the capacitance requirement is a function of the loading mismatch between the two converters. The worst-case mismatch is when one converter is at full load while the other is at no load or in shutdown. Use low-ESR ceramic capacitors with high ripple-current capability at the input. Assume the contribution from the ESR and capacitor discharge equal to $50 \%$. Calculate the input capacitance and ESR required for a specified ripple using the following equations:

$$
\mathrm{ESR}_{\mathrm{IN}}=\frac{\Delta \mathrm{V}_{\mathrm{ESR}}}{\left(\mathrm{I}_{\mathrm{OUT}}+\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2}\right)}
$$

where

$$
\Delta_{\mathrm{L}}=\frac{\left(\mathrm{V}_{\text {IN }}-\mathrm{V}_{\text {OUT }}\right) \times \mathrm{V}_{\text {OUT }}}{\mathrm{V}_{\text {IN }} \times \mathrm{f}_{\text {SW }} \times \mathrm{L}}
$$

and

$$
\mathrm{C}_{\mathrm{IN}}=\frac{\mathrm{I}_{\mathrm{OUT}} \times \mathrm{D}(1-\mathrm{D})}{\Delta \mathrm{V}_{\mathrm{Q}} \times \mathrm{f}_{\mathrm{SW}}}
$$

where

$$
\mathrm{D}=\frac{\mathrm{V}_{\mathrm{OUT}}}{\mathrm{~V}_{\mathrm{IN}}}
$$

where IOUT is the maximum output current from either converter 1 or converter 2 , and $D$ is the duty cycle for that converter. fSW is the frequency of each individual converter. For example, at $\mathrm{V}_{\mathrm{IN}}=12 \mathrm{~V}, \mathrm{~V}_{\text {OUT }}=3.3 \mathrm{~V}$ at IOUT $=2 \mathrm{~A}$, and with $L=3.3 \mu \mathrm{H}$, the ESR and input capacitance are calculated for a peak-to-peak input ripple of 100 mV or less, yielding an ESR and capacitance value of $20 \mathrm{~m} \Omega$ and $6.8 \mu \mathrm{~F}$ for 1.25 MHz frequency. Use a $100 \mu \mathrm{~F}$ capacitor at low input voltages to avoid possible undershoot below the undervoltage lockout threshold during power-on and transient loading.

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Output Capacitors

The allowable output ripple voltage and the maximum deviation of the output voltage during step load currents determines the output capacitance and its ESR.

The output ripple is comprised of $\Delta \mathrm{V}_{\mathrm{Q}}$ (caused by the capacitor discharge) and $\Delta \mathrm{V}_{\mathrm{ESR}}$ (caused by the ESR of the capacitor). Use low-ESR ceramic or aluminum electrolytic capacitors at the output. For aluminum electrolytic capacitors, the entire output ripple is contributed by $\Delta \mathrm{V}_{\mathrm{ESR}}$. Use the ESROUT equation to calculate the ESR requirement and choose the capacitor accordingly. If using ceramic capacitors, assume the contribution to the output ripple voltage from the ESR and the capacitor discharge are equal. Calculate the output capacitance and ESR required for a specified ripple using the following equations:

$$
\begin{gathered}
\mathrm{ESR}_{\mathrm{OUT}}=\frac{\Delta \mathrm{V}_{\mathrm{ESR}}}{\Delta \mathrm{I}_{\mathrm{L}}} \\
\mathrm{C}_{\mathrm{OUT}}=\frac{\Delta \mathrm{I}_{\mathrm{L}}}{8 \times \Delta \mathrm{V}_{\mathrm{Q}} \times \mathrm{f}_{\mathrm{SW}}}
\end{gathered}
$$

where

$$
\Delta \mathrm{V}_{\mathrm{O} \_ \text {RIPPLE }} \cong \Delta \mathrm{V}_{\mathrm{ESR}}+\Delta \mathrm{V}_{\mathrm{Q}}
$$

where $\Delta I_{\mathrm{L}}$ is the peak-to-peak inductor current as calculated above and fSW is the individual converter's switching frequency.
The allowable deviation of the output voltage during fast transient loads also determines the output capacitance and its ESR. The output capacitor supplies the step load current until the controller responds with a greater duty cycle. The response time (tRESPONSE) depends on the closed-loop bandwidth of the converter. The high switching frequency of MAX5073 allows for higher closed-loop bandwidth, reducing $t_{\text {RESPONSE }}$ and the output capacitance requirement. The resistive drop across the output capacitor ESR and the capacitor discharge causes a voltage droop during a step load. Use a combination of lowESR tantalum and ceramic capacitors for better transient load and ripple/noise performance. Keep the maximum output voltage deviation above the tolerable limits of the
electronics being powered. When using a ceramic capacitor, assume $80 \%$ and $20 \%$ contribution from the output capacitance discharge and the ESR drop, respectively. Use the following equations to calculate the required ESR and capacitance value:

$$
\begin{gathered}
\mathrm{ESR}_{\mathrm{OUT}}=\frac{\Delta \mathrm{V}_{\mathrm{ESR}}}{\mathrm{I}_{\mathrm{STEP}}} \\
\mathrm{C}_{\mathrm{OUT}}=\frac{\mathrm{I}_{\mathrm{STEP}} \times \mathrm{t}_{\mathrm{RESPONSE}}}{\Delta \mathrm{~V}_{\mathrm{Q}}}
\end{gathered}
$$

where ISTEP is the load step and tresponse is the response time of the controller. Controller response time depends on the control-loop bandwidth.

## Boost Converter

The MAX5073 can be configured for step-up conversion since the internal MOSFET can be used as a low-side switch. Use the following equations to calculate the inductor ( $\mathrm{L}_{\mathrm{MIN}}$ ), input capacitor ( $\mathrm{C}_{\mathrm{IN}}$ ), and output capacitor (COUT) when using the converter in boost operation.

## Inductor

Choose the minimum inductor value so the converter remains in continuous mode operation at minimum output curt (IOMIN)

$$
L_{\mathrm{MIN}}=\frac{\mathrm{V}^{2}{ }_{\mathrm{IN}} \times \mathrm{D} \times \eta}{2 \times \mathrm{f}_{\mathrm{SW}} \times \mathrm{V}_{\mathrm{O}} \times \mathrm{I}_{\mathrm{OMIN}}}
$$

where

$$
\frac{V_{O}+V_{D}-V_{I N}}{V_{O}+V_{D}-V_{D S}}
$$

and $\mathrm{I}_{\mathrm{OMIN}}=0.25 \times \mathrm{l}_{\mathrm{O}}$
The $V_{D}$ is the forward voltage drop of the external Schottky diode, D is the duty cycle, and $\mathrm{V}_{\mathrm{DS}}$ is the voltage drop across the internal switch. Select the inductor with low DC resistance and with a saturation current (ISAT) rating higher than the peak switch current limit of 4.5A and 2.2A of converter 1 and converter 2 , respectively.

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Input Capacitor

The input current for the boost converter is continuous and the RMS ripple current at the input is low. Calculate the capacitor value and ESR of the input capacitor using the following equations.

$$
\begin{gathered}
\text { IN } \frac{\Delta \mathrm{I} \times \mathrm{D}}{4 \times \mathrm{f}_{\mathrm{SW}} \times \Delta \mathrm{V}_{\mathrm{Q}}} \\
\mathrm{ESR}=\frac{\Delta \mathrm{V}_{\mathrm{ESR}}}{\Delta \mathrm{I}_{\mathrm{L}}}
\end{gathered}
$$

where

$$
\Delta_{\mathrm{L}}=\frac{\left(\mathrm{V}_{\mathrm{IN}}-\mathrm{V}_{\mathrm{DS}}\right) \times \mathrm{D}}{\mathrm{~L} \times \mathrm{f}_{\mathrm{SW}}}
$$

where $V_{D S}$ is the total voltage drop across the internal MOSFET plus the voltage drop across the inductor ESR. $\Delta_{\mathrm{L}}$ is the peak-to-peak inductor ripple current as calculated above. $\Delta \mathrm{V}_{\mathrm{Q}}$ is the portion of input ripple due to the capacitor discharge and $\Delta V_{E S R}$ is the contribution due to ESR of the capacitor.

## Output Capacitor

For the boost converter, the output capacitor supplies the load current when the main switch is ON. The required output capacitance is high, especially at higher duty cycles. Also, the output capacitor ESR needs to be low enough to minimize the voltage drop due to the ESR while supporting the load current. Use the following equation to calculate the output capacitor for a specified output ripple tolerance.

$$
\begin{gathered}
\mathrm{ESR}=\frac{\Delta \mathrm{V}_{\mathrm{ESR}}}{\mathrm{I}_{\mathrm{O}}} \\
\mathrm{C}_{\mathrm{OUT}}=\frac{\mathrm{I}_{\mathrm{O}} \times \mathrm{D}_{\mathrm{MAX}}}{\Delta \mathrm{~V}_{\mathrm{Q}} \times \mathrm{f}_{\mathrm{SW}}}
\end{gathered}
$$

$\mathrm{I}_{\mathrm{O}}$ is the load current, $\Delta \mathrm{V}_{\mathrm{Q}}$ is the portion of the ripple due to the capacitor discharge and $\Delta \mathrm{V}_{\mathrm{ESR}}$ is the contribution due to the ESR of the capacitor. $\mathrm{D}_{\text {MAX }}$ is the maximum duty cycle at minimum input voltage.

## Power Dissipation

The MAX5073 includes a high-frequency, low RDS_ON switching MOSFET. At $+85^{\circ} \mathrm{C}$, the $\mathrm{R}_{\mathrm{DS}}$ on of the internal switch for converter 1 and converter $\overline{2}$ are $290 \mathrm{~m} \Omega$ and $630 \mathrm{~m} \Omega$, respectively. The DC loss is a function of the

RMS current in the switch while the switching loss is a function of switching frequency and input voltage. Use the following equations to calculate the RMS current, DC loss, and switching loss of each converter. The MAX5073 device is available in a thermally enhanced package and can dissipate up to 2.7 W at $+70^{\circ} \mathrm{C}$ ambient temperature. The total power dissipation in the package must be limited so the junction temperature does not exceed its absolute maximum rating of $+150^{\circ} \mathrm{C}$ at maximum ambient temperature.
For the buck converter:

$$
\begin{gathered}
I_{\mathrm{RMS}}=\sqrt{\left(I^{2} \mathrm{DC}^{+I^{2}} \mathrm{PK}+\left(l_{\mathrm{DC}} \times l_{\mathrm{PK}}\right)\right) \times \frac{\mathrm{D}_{\mathrm{MAX}}}{3}} \\
\mathrm{P}_{\mathrm{DC}}=I^{2}{ }_{\mathrm{RMS}} \times \mathrm{R}_{\mathrm{DS}(\mathrm{ON}) \mathrm{MAX}}
\end{gathered}
$$

where

$$
\begin{aligned}
& \mathrm{I}_{\mathrm{DC}}=\mathrm{I}_{\mathrm{O}}-\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2} \\
& \mathrm{I}_{\mathrm{PK}}=\mathrm{I}_{\mathrm{O}}+\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2}
\end{aligned}
$$

See the Electrical Characteristics table for the $R_{D S(O N) M A X}$ value.

$$
\mathrm{P}_{\mathrm{SW}}=\frac{\mathrm{V}_{\text {INMAX }} \times \mathrm{I}_{\mathrm{O}} \times\left(\mathrm{t}_{\mathrm{R}}+\mathrm{t}_{\mathrm{F}}\right) \times \mathrm{f}_{\mathrm{SW}}}{4}
$$

For the boost converter:

$$
\begin{gathered}
\mathrm{I}_{\mathrm{RMS}}=\sqrt{\left(\mathrm{I}^{2} \mathrm{DC}^{+I^{2}} \mathrm{PK}+\left(\mathrm{I}_{\mathrm{DC}} \times \mathrm{I}_{\mathrm{PK}}\right)\right) \times \frac{\mathrm{D}_{\mathrm{MAX}}}{3}} \\
\mathrm{I}_{\mathrm{IN}}=\frac{\mathrm{V}_{\mathrm{O}} \times \mathrm{I}_{\mathrm{O}}}{\mathrm{~V}_{\mathrm{IN}} \times \eta} \\
\Delta \mathrm{I}_{\mathrm{L}}=\frac{\left(\mathrm{V}_{\mathrm{IN}}-\mathrm{V}_{\mathrm{DS}}\right) \times \mathrm{D}}{\mathrm{~L} \times \mathrm{f}_{\mathrm{SW}}} \\
\mathrm{I}_{\mathrm{DC}}=\mathrm{I}_{\mathrm{IN}}-\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2} \\
\mathrm{I}_{\mathrm{PK}}=\mathrm{I}_{\mathrm{IN}}+\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2}
\end{gathered}
$$

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

$$
P_{D C}=I^{2} \mathrm{RMS} \times R_{D S}(\mathrm{ON}) M A X
$$

where $V_{D S}$ is the drop across the internal MOSFET. See the Electrical Characteristics for the $R_{D S}(O N) M A X$ value.

$$
\mathrm{P}_{\mathrm{SW}}=\frac{\mathrm{V}_{\mathrm{O}} \times \mathrm{I}_{\mathrm{N}} \times\left(\mathrm{t}_{\mathrm{R}}+\mathrm{t}_{\mathrm{F}}\right) \times \mathrm{f}_{\mathrm{SW}}}{4}
$$

where $t_{R}$ and $t_{F}$ are rise and fall times of the internal MOSFET. The $t_{R}$ and $t_{F}$ are typically 20ns, and can be measured in the actual application.
The supply current in the MAX5073 is dependent on the switching frequency. See the Typical Operating Characteristics to find the supply current of the MAX5073 at a given operating frequency. The power dissipation ( $\mathrm{P}_{\mathrm{S}}$ ) in the device due to supply current ( $\mathrm{I}_{\mathrm{S}}$ ) is calculated using fowing equation.

$$
P_{S}=V_{I N M A X} \times I_{\text {SUPPLY }}
$$

The total power dissipation $\mathrm{P}_{\mathrm{T}}$ in the device is:

$$
\mathrm{P}_{\mathrm{T}}=\mathrm{P}_{\mathrm{DC} 1}+\mathrm{P}_{\mathrm{DC} 2}+\mathrm{P}_{\mathrm{SW} 1}+\mathrm{P}_{\mathrm{SW}}+\mathrm{P}_{\mathrm{S}}
$$

where $P_{D C 1}$ and $P_{D C 2}$ are DC losses in converter 1 and converter 2, respectively. PSW1 and PSW2 are switching losses in converter 1 and converter 2.
Calculate the temperature rise of the die using the following equation:

$$
\mathrm{T}_{\mathrm{J}}=\mathrm{T}_{\mathrm{C}}+\left(\mathrm{P}_{\mathrm{T}} \times \theta_{\mathrm{JC}}\right)
$$

where, $\theta_{\mathrm{Jc}}$ is the junction-to-case thermal impedance of the package equal to $+2^{\circ} \mathrm{C} / \mathrm{W}$. Solder the exposed pad of the package to a large copper area to minimize the case-to-ambient thermal impedance. Measure the temperature of the copper area near the device at a worst-case condition of power dissipation and use $+2^{\circ} \mathrm{C} / \mathrm{W}$ as $\theta_{\mathrm{JC}}$ thermal impedance. The case-to-ambient thermal impedance ( $\theta_{\mathrm{C}-\mathrm{A}}$ ) is dependent on how well the heat is transferred from the PC board to the ambient. Use a large copper area to keep the PC board temperature low. The $\theta_{C-A}$ is usually in the $+20^{\circ} \mathrm{C} / \mathrm{W}$ to $+40^{\circ} \mathrm{C} / \mathrm{W}$ range .

## Compensation

The MAX5073 provides an internal transconductance amplifier with its inverting input and its output available to the user for external frequency compensation. The flexibility of external compensation for each converter offers wide selection of output filtering components, especially the output capacitor. For cost-sensitive applications, use high-ESR aluminum electrolytic capacitors; for component size-sensitive applications, use low-ESR tantalum
or ceramic capacitors at the output. The high switching frequency of MAX5073 allows use of ceramic capacitors at the output.
Choose all the passive power components that meet the output ripple, component size, and component cost requirements. Choose the small-signal components for the error amplifier to achieve the desired closed-loop bandwidth and phase margin. Use a simple pole-zero pair (Type II) compensation if the output capacitor ESR zero frequency is below the unity-gain crossover frequency ( f C ). Type III compensation is necessary when the ESR zero frequency is higher than $\mathrm{f}_{\mathrm{C}}$ or when compensating for a continuous mode boost converter that has a right-half-plane zero.
Use the following procedure 1 to calculate the compensation network components when $\mathrm{f}_{\mathrm{ZERO}}, \mathrm{ESR}<\mathrm{f}_{\mathrm{C}}$.

## Buck Converter Compensation

## Procedure 1 (See Figure 6)

1) Calculate the fZERO,ESR and LC double pole:

2) Calculate the unity-gain crossover frequency as:

$$
\mathrm{f}_{\mathrm{C}}=\frac{\mathrm{f}_{\mathrm{SW}}}{20}
$$

If the $f_{Z E R O, E S R}$ is lower than $f_{C}$ and close to $f_{L C}$, use a Type II compensation network where $R_{F} C_{F}$ provides a midband zero fmid,zero, and RFCCF provides a highfrequency pole.
3) Calculate modulator gain GM at the croser frequency.


Figure 6. Type II Compensation Network

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$$
\mathrm{G}_{\mathrm{M}}=\frac{\mathrm{V}_{\text {IN }}}{\mathrm{V}_{\mathrm{OSC}}} \times \frac{\mathrm{ESR}}{\mathrm{ESR}+\left(2 \pi \times \mathrm{f}_{\mathrm{C}} \times \mathrm{L}_{\text {OUT }}\right)} \times \frac{0.8}{V_{\text {OUT }}}
$$

where $\mathrm{V}_{\text {OSC }}$ is a peak-to-peak ramp amplitude equal to 1 V .
The transconductance error amplifier gain is:

$$
G_{E / A}=g_{m} \times R_{F}
$$

The total loop gain at $\mathrm{f}_{\mathrm{C}}$ sho be equal to 1

$$
G_{M} \times G_{E / A}=1
$$

or

$$
\mathrm{R}_{\mathrm{F}}=\frac{\mathrm{V}_{\mathrm{OSC}}\left(\mathrm{ESR}+2 \pi \times \mathrm{f}_{\mathrm{C}} \times \mathrm{L}_{\text {OUT }}\right) \mathrm{V}_{\text {OUT }}}{0.8 \times \mathrm{V}_{\text {IN }} \times \mathrm{g}_{\mathrm{m}} \times \mathrm{ESR}}
$$

4) Place a zero at or below the LC double pole:

$$
C_{F}=\frac{1}{2 \pi \times R_{F} \times f_{L C}}
$$

5) Place a high-frequency pole at $f_{P}=0.5 \times f$ fw .

## Procedure 2 (see Figure 7)

If the output capacitor used is a low-ESR ceramic type, the ESR frequency is usually far away from the targeted unity crossover frequency ( f C ). In this case, Type III compensation is recommended. Type III compensation provides two-pole zero pairs. The locations of the zero and poles should be such that the phase marginaks at $\mathrm{f}_{\mathrm{C}}$.
The ${ }^{\frac{f_{C}}{f_{Z}}=\frac{f_{P}}{f_{C}}=5}$ is a good number to get about $60^{\circ}$ phase margin at f c. However, it is important to place the two zeros at or below the double pole to avoid the conditional stability issue.

1) Select a crossover frequency:

$$
\mathrm{f}_{\mathrm{C}} \leq \frac{\mathrm{f}_{\mathrm{S}} \mathrm{~W}}{20}
$$

2) Calculate the LC double-pole frequency, fLC:

$$
\mathrm{f}_{\mathrm{LC}}=\frac{1}{2 \pi \times \sqrt{\text { LOUT }^{\times C_{\text {OUT }}}}}
$$

3) Place a zero

$$
f_{Z}=\frac{1}{2 \pi \times R_{F} \times C_{F}} \text { at } 0.75 \times f_{L C}
$$



Figure 7. Type III Compensation Network
where:

$$
C_{F}=\frac{1}{2 \pi \times 0.75 \times f_{L C} \times R_{F}}
$$

and $R_{F} \geq 10 k \Omega$.
4) Calculate $\mathrm{C}_{\mathrm{I}}$ for a target unity crossoverequency, $\mathrm{f}_{\mathrm{C}}$ :

$$
\mathrm{C}_{\mathrm{I}}=\frac{2 \pi \times \mathrm{f}_{\mathrm{C}} \times \mathrm{L}_{\mathrm{OUT}} \times \mathrm{C}_{\text {OUT }} \times \mathrm{V}_{\text {OSC }}}{\mathrm{V}_{\text {IN }} \times \mathrm{R}_{\mathrm{F}}}
$$

5) Place a pole ${ }^{\left(f_{P 1}=\frac{1}{2 \pi \times R_{\mid} \times C_{l}}\right)}$ at f ZERO,ESR.

$$
\mathrm{R}_{\mathrm{I}}=\frac{1}{2 \pi \times \mathrm{f}_{\mathrm{ZERO}, \mathrm{ESR}} \times \mathrm{C}_{\mathrm{I}}}
$$

6) Place a second zero, $\mathrm{f}_{\mathrm{Z} 2}$, at $0.2 \times \mathrm{fc}$ or at fLC , whichever is lower.

$$
\mathrm{R} 1=\frac{1}{2 \pi \times \mathrm{f}_{\mathrm{Z} 2} \times \mathrm{C}_{I}}-\mathrm{R}_{\mathrm{l}}
$$

7) Placece a second pole ${ }^{\left(\mathrm{f}_{\mathrm{P} 2}=\frac{1}{2 \pi \times \mathrm{R}_{\mathrm{F}} \times \mathrm{C}_{\mathrm{CF}}} \text { ) }\right.}$ at $1 / 2$ the swiing frequency.

$$
\left.\left.C_{C F}=\frac{C_{F}}{(2 \pi \times 0.5 \times f}{ }_{S W} \times R_{F} \times C_{F}\right)-1\right)
$$



Figure 8. Buck-Boost Application

## Boost Converter Compensation

The boost converter compensation gets complicated due to the presence of a right-half-plane zero fZERO,RHP. The right-half-plane zero causes a drop in-phase while adding positive (+1) slope to the gain curve. It is important to drop the gain significantly below unity before the RHP frequency. Use the following procedure to calculate the compensation components.

1) Calculate the LC double-pole frequency, $F_{L C}$, and the right half plane zero frequency.

$$
\begin{aligned}
& \mathrm{f}_{\mathrm{LC}}=\frac{1-\mathrm{D}}{2 \pi \times \sqrt{\text { LOUT }_{\text {OUT }}}} \\
& \mathrm{f}_{\mathrm{ZERO}, \mathrm{RHP}}=\frac{(1-\mathrm{D})^{2} \mathrm{R}_{(\mathrm{MIN})}}{2 \pi \times \mathrm{L}_{\text {OUT }}}
\end{aligned}
$$

where:

$$
\begin{aligned}
& \mathrm{D}=1-\frac{\mathrm{V}_{\text {IN }}}{\mathrm{V}_{\text {OUT }}} \\
& \mathrm{R}_{(\mathrm{MIN})}=\frac{\mathrm{V}_{\text {OUT }}}{\mathrm{I}_{\text {OUT(MAX) }}}
\end{aligned}
$$

Target the unity-gain crossovfrequency for:

$$
\mathrm{f}_{\mathrm{C}} \leq \frac{\mathrm{f}_{\text {ZERO,RHP }}}{5}
$$

2) Place a zero ${ }^{\left(f_{Z 1}=\frac{1}{2 \pi \times R_{F} \times C_{F}}\right)}$ at $0.75 \times f_{L C}$.

$$
C_{F}=\frac{1}{2 \pi \times 0.75 \times f_{L C} \times R_{F}}
$$

where $R_{F} \geq 10 k \Omega$.

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

3) Calculate $C_{\mid}$for a target crossoverequency, $f_{C}$ :

$$
\mathrm{C}_{\mathrm{I}}=\frac{\mathrm{V}_{\mathrm{OSC}}\left[(1-\mathrm{D})^{2}+\omega_{C}{ }^{2} L_{O} C_{O}\right]}{\omega_{C} R_{F} V_{I N}}
$$

where $\omega C=2 \pi f_{C}$
4) Place a pole ${ }^{\left(f_{P 1}=\frac{1}{2 \pi \times R_{\mid} \times C_{l}}\right)}$ at $f_{Z E R O, R H P}$.

$$
\mathrm{R}_{\mathrm{I}}=\frac{1}{2 \pi \times \mathrm{f}_{\mathrm{ZERO}}, \mathrm{R}_{\mathrm{HP}} \times \mathrm{C}_{\mathrm{I}}}
$$

5) Place the second zero $\left(f_{Z 2}=\frac{1}{2 \pi \times R 1 \times C_{I}}\right)$ at $f_{\text {LC }}$.

$$
\mathrm{R} 1=\frac{1}{2 \pi \times f_{L C} \times C_{I}}-\mathrm{R}_{I}
$$

) Place the second pole $\left(f_{P 2}=\frac{1}{2 \pi \times R_{F} \times C_{C F}}\right)$ at $1 / 2$ the swhing frequency.

$$
C_{C F}=\frac{C_{F}}{\left(2 \pi \times 0.5 \times f_{S W} \times R_{F} \times C_{F}\right)-1}
$$

## Improving Noise Immunity

In applications where the MAX5073 are subject to noisy environments, adjust the controller's compensation to improve the system's noise immunity. In particular, highfrequency noise coupled into the feedback loop causes jittery duty cycles. One solution is to lower the crossover frequency (see the Compensation section).

## PC Board Layout Guidelines

Careful PC board layout is critical to achieve low switching losses and clean, stable operation. This is especially true for dual converters where one channel can affect the other. Refer to the MAX5073 EV kit data sheet for a specific layout example. Use a multilayer board whenever possible for better noise immunity. Follow these guidelines for good PC board layout:

1) For SGND, use a large copper plane under the IC and solder it to the exposed paddle. To effectively use this copper area as a heat exchanger between the PC board and ambient, expose this copper area on the top and bottom side of the PC board. Do not make a direct connection from the exposed pad copper plane to SGND ( pin 25 ) underneath the IC.
2) Isolate the power components and high-current path from the sensitive analog circuitry.
3) Keep the high-current paths short, especially at the ground terminals. This practice is essential for stable, jitter-free operation.
4) Connect SGND and PGND together close to the IC at the ground terminals of VL and $\mathrm{V}+$ bypass capacitors. Do not connect them together anywhere else.
5) Keep the power traces and load connections short. This practice is essential for high efficiency. Use thick copper PC boards (2oz vs. 1oz) to enhance full-load efficiency.
6) Ensure that the feedback connection to COUT is short and direct.
7) Route high-speed switching nodes (BST_/VDD_, SOURCE_) away from the sensitive analog areas (BYPASS, COMP_, and FB_). Use the internal PC board layer for SGND as EMI shields to keep radiated noise away from the IC, feedback dividers, and analog bypass capacitors.

### 2.2MHz, Dual-Output Buck or Boost Converter with Internal Power MOSFETs

## Layout Procedure

1) Place the power components first, with ground terminals adjacent (inductor, $\mathrm{C}_{\mathrm{IN}_{-}}$, and $\mathrm{C}_{\text {Out_) }}$ ). Make all these connections on the top layer with wide, copperfilled areas (2oz copper recommended).
2) Group the gate-drive components (bootstrap diodes and capacitors, and VL bypass capacitor) together near the controller IC.
3) Make the DC-DC controller ground connections as follows:

## Ordering Information (continued)

| PART | TEMP RANGE | PIN- <br> PACKAGE | PACKAGE <br> CODE |
| :---: | :---: | :---: | :---: |
| MAX5073ETI | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 28 Thin QFN-EP* <br> $(5 \mathrm{~mm} \times 5 \mathrm{~mm})$ | T2855-6 |
| MAX5073ETI $+-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 28 Thin QFN-EP* <br> $(5 \mathrm{~mm} \times 5 \mathrm{~mm})$ | T2855-6 |  |

*EP = Exposed pad.
+Denotes lead-free package.
a) Create a small-signal ground plane underneath the IC.
b) Connect this plane to SGND and use this plane for the ground connection for the reference (BYPASS), enable, compensation components, feedback dividers, and OSC resistor.
c) Connect SGND and PGND together near the input bypass capacitors and the IC (this is the only connection between SGND and PGND).

## Chip Information

TRANSISTOR COUNT: 5994
PROCESS: BiCMOS

## REVISION HISTORY

| REVISION <br> NUMBER | REVISION <br> DATE | DESCRIPTION | PAGES <br> CHANGED |
| :---: | :---: | :---: | :---: |
| 5 | $5 / 14$ | Removed automotive reference under Applications section on Page 1 | 1 |

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